

DK-60610-A2-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE)

CB TEST CERTIFICATE

Product ICX (Capacitor discharge function)

Name and address of the applicant ON SEMICONDUCTOR

10F 16 Lane 35 Jihu Rd, Neihu District Taipei, Taiwan

Name and address of the manufacturer ON SEMICONDUCTOR

10F 16 Lane 35 Jihu Rd, Neihu District Taipei, Taiwan

Name and address of the factory ON SEMICONDUCTOR

5005 East McDowell Rd, Phoenix, AZ, 85008 Note: When more than one factory, please report on page 2

U.S.A

ON

Additional Information on page 2

Ratings and principal characteristics (Optional) 40 Vdc max.

Trademark (if any)

Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref. NCP1240, 40ABCD, See Page 2

Additional information (if necessary may also be reported on page 2)

National Differences specified in the CB Test Report.

Additional Information on page 2

A sample of the product was tested and found to be in conformity with

IEC 62368-1(ed.2)

As shown in the Test Report Ref. No. which forms part

of this Certificate

E486692-4787566709-1 Amendment 2 issued on 2017-08-23

This CB Test Certificate is issued by the National Certification Body



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK

UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

Date: 2017-08-23 Signature:

Original Issue Date: 2016-12-30

For full legal entity names see www.ul.com/ncbnames

Jan-Erik Storgaard



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Model Details:

NCP1246, 46ABCDE

NCP1240, 40ABCD

NCP1244, 44ABCD

NCP1247, 47ABCD

NCP1248, 48ABCD

NOD4240, 4040AD

NCP1340, 1340AB

NCP1341, 1341AB

NCP1342, 1342ABCD

NCP1343, 1343ABCD

NCP1615, NCP1615ABG

NCP12400, 400VWXYZf, DAP046, SCY99218

SCY99146, 46ABCDE

SCY99126, DAP028A

SCY99158, DAP027AB

SCY99194, DAP041

NCP1616, 1616AB

SCY99157, SCY157Axx xx=nil for 100 kHz or 65 for 65kHz

All of above A or B or C or D or E or is specific device code or blank

Factories:

ON Semiconductor Philippines Inc

Golden Mile Business Park Special Economic Zone Governors Dr, Carmona, Cavite

Philippines

Additional Information:

The original report was modified to include the following changes/additions:

- 1. Add new models NCP1616xx.
- 2. Redefine the end's variables (A or B or C or D or E) of most models name to specific device code or blank.
- 3. Add bridge diode rating (D101, D102, D106 and D107) in components on EVB.

Additional information (if necessary)



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Signature: U Jan-Erik Storgaard